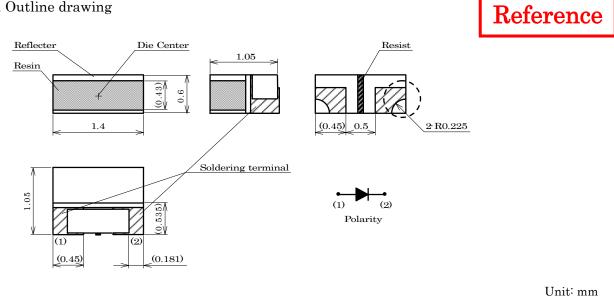
SPE	CIFICATI	ONS				1/10
1. Scope of Application These specifications apply to CL	-963-1W-C0	1-TS		[Refe	erence
2. Part code						
2. Part code Series					21 -	TS
	Approved	Checked	Drawn	Symbol		CITILED
				Name	CL-96	53-1W-C01-TS
				Drawing No	5	
Mark Date Description Appro.		CITIZI	EN ELECTR	RONICS CC).,LTD.	

SPECIFICATIONS

3. Outline drawing



Tolerance: ± 0.1 Dimensions do not include burr.

(Ta=25°C)

4. Performance

(1) Ab	solute	Maximum	Rating	r S
		Parameter		Symbol

Parameter	Symbol	Rating Value	Unit
Power Dissipation	Pd	34	mW
Forward Current	$I_{\rm F}$	10	mA
Forward Pulse Current *	$I_{\rm FP}$	50 *	mA
Reverse Voltage	$V_{\rm R}$	4	V
Operating Temperature	Тор	$-25 \sim +80$	°C
Storage Temperature	Tst	-30 ~ +85	°C

* Duty $\leq 1/10$, Pulse width ≤ 0.1 msec

(2) Electro-optical Characteristic

$(Ta=25^{\circ}C)$

Parameter	Symbol	Condition	MIN	TYP	MAX	Unit
Forward Voltage	$V_{\rm F}$	IF=7mA	2.38	2.85	3.42	V
Reverse Current	Ir	$V_R=4V$	_	—	2	μA
Luminous Intensity	Iv	IF=7mA	362	520	754	mcd

Note 1) The tolerance of Forward Voltage measurement is $\pm 3\%$ at our tester.

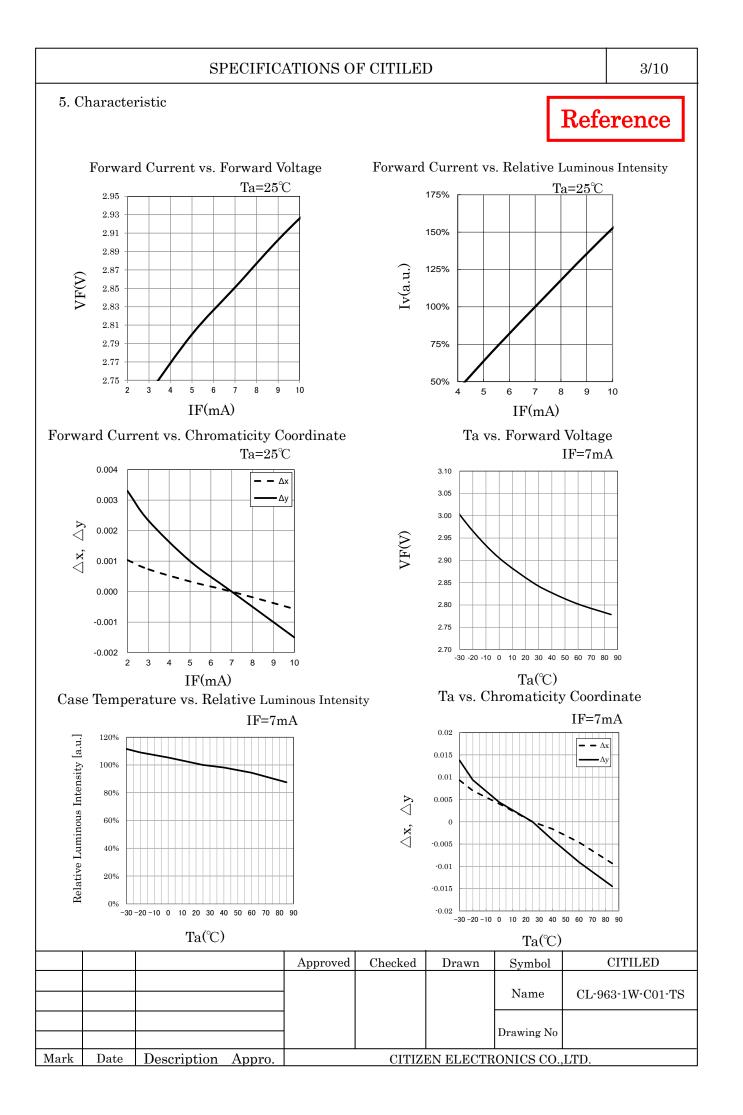
Note 2) The tolerance of Luminous Intensity measurement is $\pm 10\%$ at our tester.

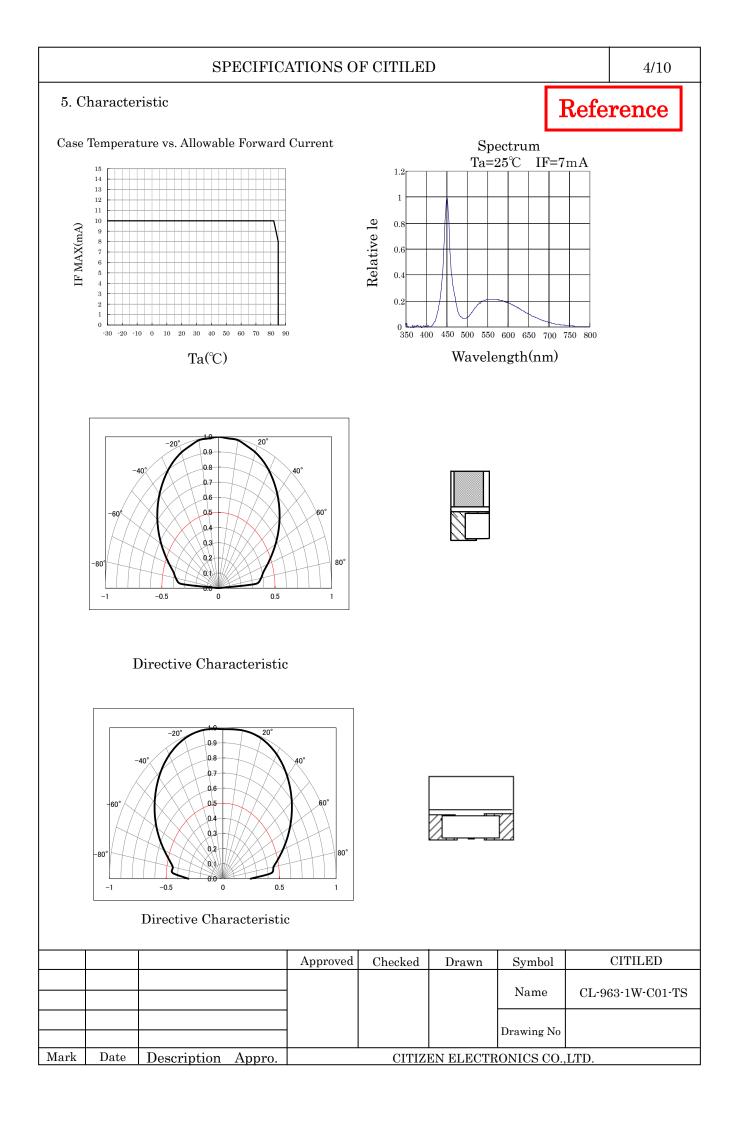
Note 3) For handling, please apply CMOS LSI or equivalent to prevent any electrostatic effect.

Note 4) Please be aware that the above electro-optical characteristics are guaranteed when applying the current values shown in the table.

Please consult us when this product is used under any other conditions.

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			Approved	Checked	Drawn	Symbol	CITILED
			-			Name	CL-963-1W-C01-TS
			-			Drawing No	
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6. Reliability

Reference

(1) Details of the tests

Test Item	Test Condition
Life Test in Continuous Operation	25±3°C, IF=10 mA \times 500 $^{+24}_{-12}$ hours
High Temperature Storage Test	85^{+5}_{-3} °C × 500 $^{+24}_{-12}$ hours
Low Temperature Storage Test	-30^{+3}_{-5} °C × 500 $^{+24}_{-12}$ hours
Moisture-proof Test	$60 \pm 2^{\circ}$ C, 90 $\pm 5\%$ RH for 500 $^{+24}_{-12}$ hours
Thermal Shock Test	-30°C × 30 minutes – 85°C × 30 minutes, 5 cycle
Solder Heat Resistance Test	Recommended temperature profile (reflow soldering) after pretreatment [*] \times 2, (2nd test must be started after the samples are stabilized thermally.)

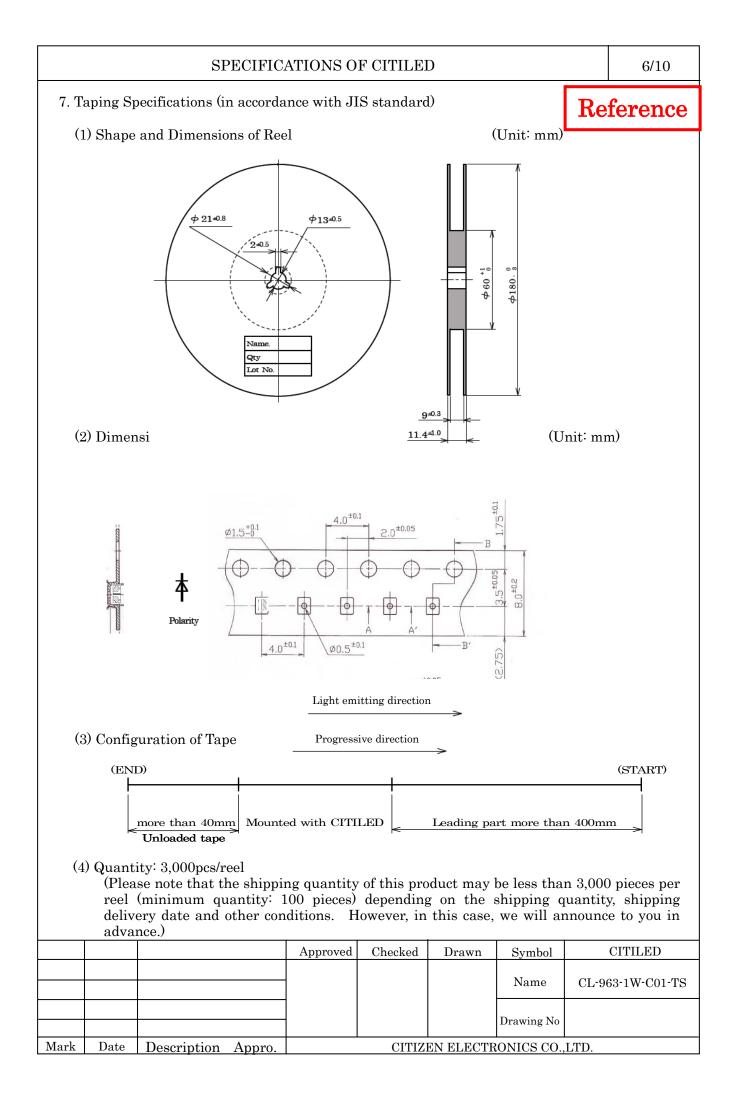
(2) Judgment Criteria of Failure for Reliability Test

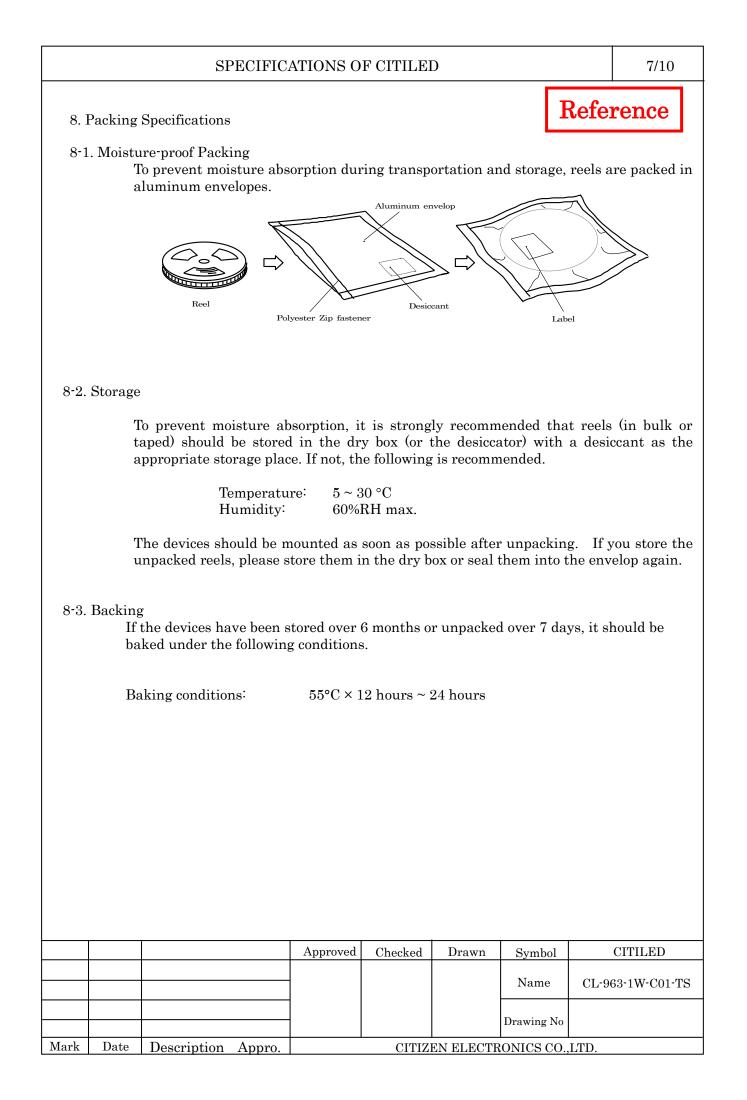
Measuring Item	Symbol	Measuring Condition	Judgment Criteria for Failure
Forward Voltage	$V_{\rm F}$	$I_{F}=7 mA$	>U×1.2
Reverse Current	Ir	$V_R=4 V$	>U×2
Luminous Intensity	Iv	I _F =7mA	<s×0.5< td=""></s×0.5<>

U means the upper limit of the specified characteristics. S means the initial value.

Note 1: Measurement shall be taken between 2 hours and 24 hours, having returned the test pieces to the normal ambient conditions after the completion of each test.

			Approved	Checked	Drawn	Symbol	CITILED
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						Drawing No	
Mark	Date	Description Appro.	CITIZEN ELECTRONICS CO.,LTD.				





9. Precautions

Reference

9-1. Soldering

(1) Manual soldering

- 1) Solder of 96.5Sn 3Ag 0.5Cu is recommended.
- 2) Before soldering every time, make baking to units. By manual soldering, it is the possibility of crack due to the moisture absorption in the resin portion.
- 3) Use a soldering iron of 25W or smaller. Adjust the temperature of the soldering iron below 350°C.
- 4) Force or stress must not be applied to the resin portion while soldering.
- 5) Finish soldering within 3 seconds.
- 6) Handle the devices only after temperature is cooled down.

(3) Lead free soldering

- Following soldering paste is recommended Melting temperature: 216 ~ 220°C. Composition: 96.5Sn 3Ag 0.5Cu
- 2) The temperature profile at the top surface of the parts is recommended as shown below.
- 3) It is requested that products should be handled after their temperature has dropped down to the normal room temperature.

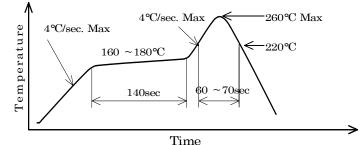


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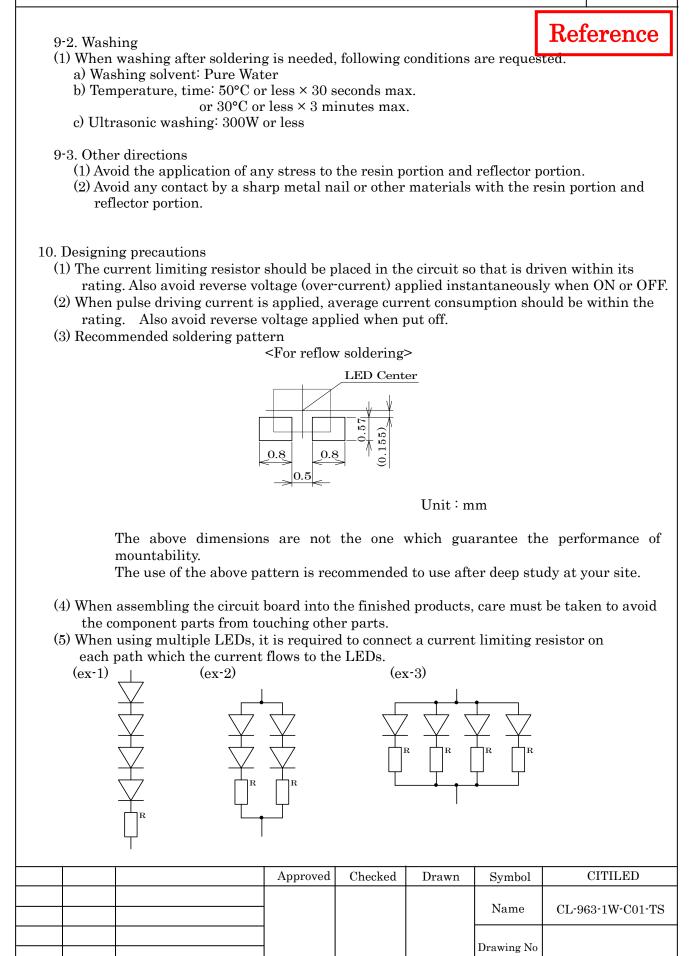
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Mark

Date

Description Appro.

CITIZEN ELECTRONICS CO., LTD.

CL-963-1W-C01-TS rank

1.Rank data

	Ta=25°C	
Iv Rank	IF=7mA	
Rank	Iv(mcd)	
А	362 - 754	

VF Rank	Ta=25℃ IF=7mA
Rank	VF(V)
W	2.38-3.42

		Chrom	aticity Rai	ık		
0.340						
0.320					•	
0.300						
0.280			\swarrow	\sim		
0.260		\checkmark				
0.240	\langle	\rightarrow				
0.220	$\overline{}$					
0.200	0.260	0.270	0.280	0.290	0.300	

Chromaticity coordinates are within the area surrounded

		IA=25 C IF=7mA
Rank 1	Х	у
а	0.263	0.210
b	0.257	0.240
с	0.267	0.259
d	0.273	0.229

Rank 2	Х	У		
a	0.273	0.229		
b	0.267	0.259		
с	0.277	0.278		
d	0.284	0.249		

Rank 3	Х	У		
а	0.284	0.249		
b	0.277	0.278		
с	0.288	0.297		
d	0.294	0.268		

Rank 4	X	у
а	0.294	0.268
b	0.288	0.297
с	0.298	0.317
d	0.304	0.287

2.Rank notation

by a, b, c and d.(Tolerance: ± 0.02)

Luminance intensity rank is mentioned first, Followed by chromaticity rank second and VF rank third. Eg "A1W"

			Approved	Checked	Drawn	Symbol	CITILED
						Name	CL-963-1W-C01-TS
						Drawing No	
Mark	Date	Description Appro.	CITIZEN ELECTRONICS CO.,LTD.				

Reference

 $T_0 - 25^{\circ}$